



TO-263-2L Plastic-Encapsulate MOSFETS

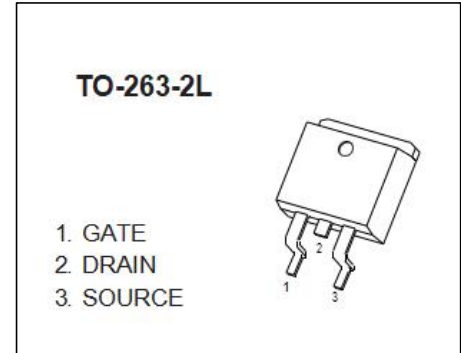
CCMA160N04T N-Channel Power MOSFET

V _{DSS}	R _{DS(ON)} (Typ.)	I _D
40 V	2.0mΩ@10V 2.3mΩ@4.5V	160A

DESCRIPTION

The CCMA160N04T provides excellent R_{DS(ON)} with low gate charge.

It can be used in a wide variety of applications.



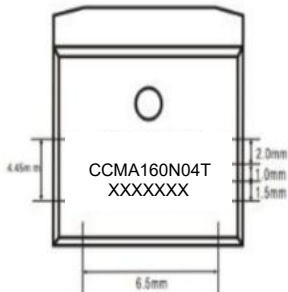
FEATURES

- Power MOSFET for automotive applications
- 100% Avalanche tested
- 175°C operating temperature
- Green Product (RoHS compliant)
- AEC Q101 Qualified

APPLICATIONS

- Electronic water pump
- Electric steering
- ESC

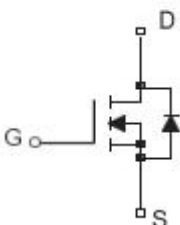
MARKING



CCMA160N04T =Part No.

XXXXXXX = Code

EQUIVALENT CIRCUIT



ABSOLUTE MAXIMUM RATINGS($T_c=25^{\circ}\text{C}$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	40	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current	I_D	160	A
Pulsed Drain Current ¹	I_{DM}	640	A
Single Pulse Avalanche Energy ²	E_{AS}	676	mJ
Total Power Dissipation	P_D	100	W
Thermal Resistance from Junction to Case	$R_{\theta JC}$	1.5	$^{\circ}\text{C}/\text{W}$
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55~ +175	$^{\circ}\text{C}$
Soldering Temperature , for 10S(1.6mm from case)	-	260	$^{\circ}\text{C}$

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Limited by T_{Jmax} , starting $T_J = 25^{\circ}\text{C}$, $L = 0.5\text{mH}$, $R_G = 25\Omega$, $I_{AS} = 52\text{A}$, $V_{GS} = 10\text{V}$.

MOSFET ELECTRICAL CHARACTERISTICS

TC=25°C unless otherwise specified

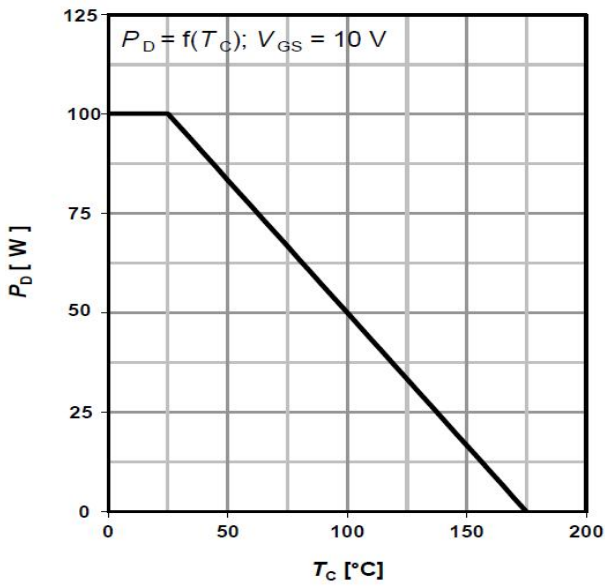
Parameter	Symbol	Test Condition	Min	Type	Max	Unit
Off characteristics						
Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	40			V
Zero gate voltage drain current	I_{DSS}	$V_{DS} = 32V, V_{GS} = 0V$			1	μA
Gate-body leakage current	I_{GSS}	$V_{GS} = \pm 20V, V_{DS} = 0V$			± 100	nA
On characteristics						
Gate threshold voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	1.1	1.5	2.4	V
Drain-source on-resistance	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 10A$		2.0	2.2	m Ω
		$V_{GS} = 4.5V, I_D = 10A$		2.3	2.5	m Ω
Transconductance	g_{fs}	$V_{DS} = 10V, I_D = 10A$		72		S
Dynamic characteristics						
Input Capacitance	C_{iss}	$V_{DS} = 25V, V_{GS} = 0V, f = 1MHz$		13450		pF
Output Capacitance	C_{oss}			797		
Reverse Transfer Capacitance	C_{rss}			754		
Gate resistance	R_g	$V_{GS} = 0V, V_{DS} = 0V, f = 1MHz$		0.8		Ω
Switching characteristics¹						
Total Gate Charge	Q_g	$V_{DD} = 32V, V_{GS} = 10V, I_D = 160A$		62	82	nC
Gate-Source Charge	Q_{gs}			16	21	
Gate-Drain Charge	Q_{gd}			13	20	
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 20V, V_{GS} = 10V, I_D = 160A, R_G = 3.5\Omega$		7		ns
Turn-on rise time	t_r			4		
Turn-off delay time	$t_{d(off)}$			14		
Turn-off fall time	t_f			7		
Drain-source Diode characteristics						
Diode Forward Voltage ¹	V_{SD}	$V_{GS} = 0V, I_S = 60A, T_J = 25^\circ C$		0.8	1.2	V
Continuous Source Current ²	I_S	$T_C = 25^\circ C$			160	A
Pulsed drain-source diode forward current	I_{SM}	—			640	A
Reverse recovery time	t_{rr}	$V_R = 20V, I_F = 50A, di/dt = 100A/\mu s$		45		ns
Reverse recovery charge	Q_{rr}			41		nC

Note :

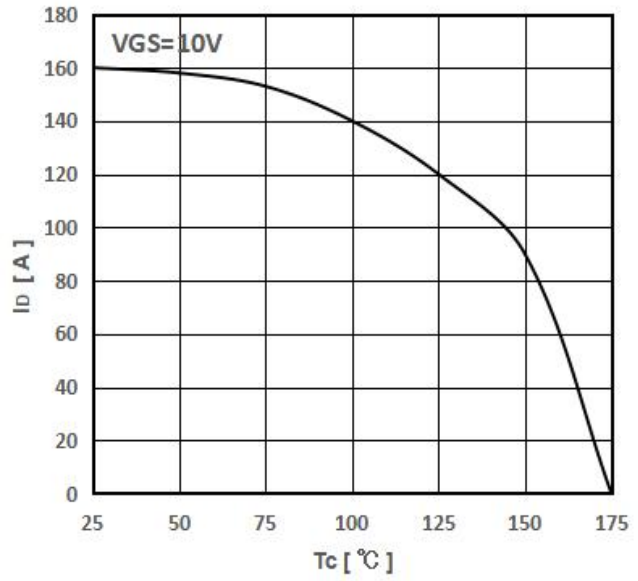
1. Pulse Test: Pulse Width $\leq 400\mu s$, Duty Cycle $\leq 2\%$.
2. The parameter is not subject to production test-verified by design/characterization.

Typical Characteristics

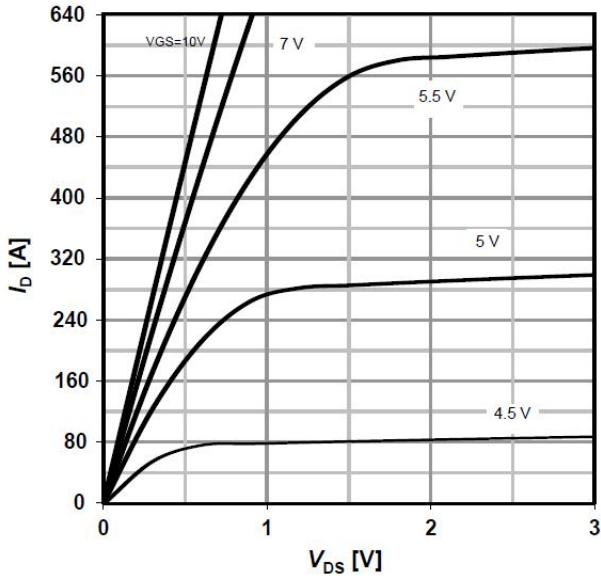
PD -- Tc



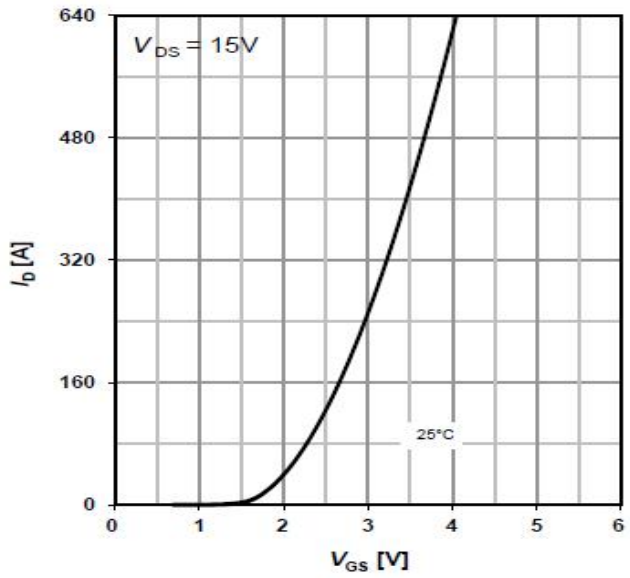
ID -- Tc



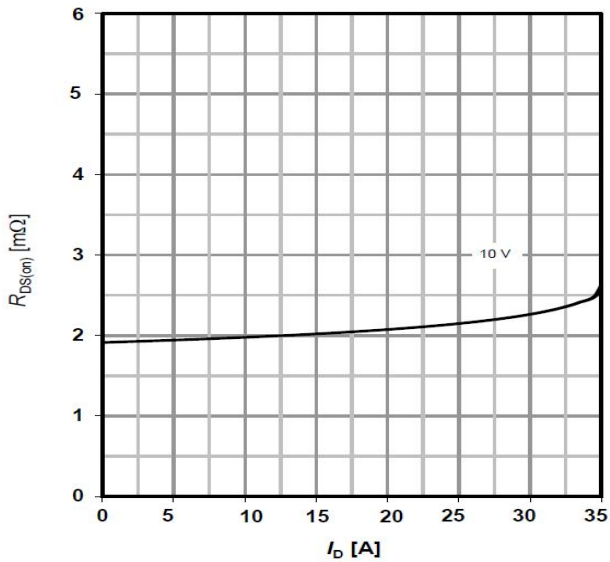
ID -- VDS



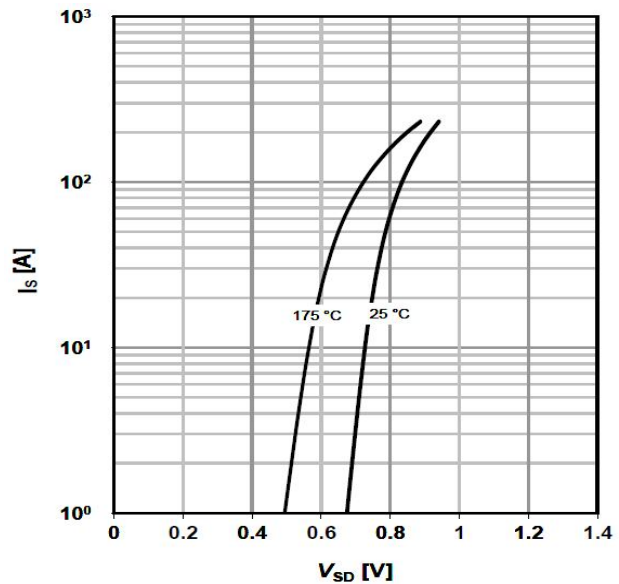
ID -- VGS



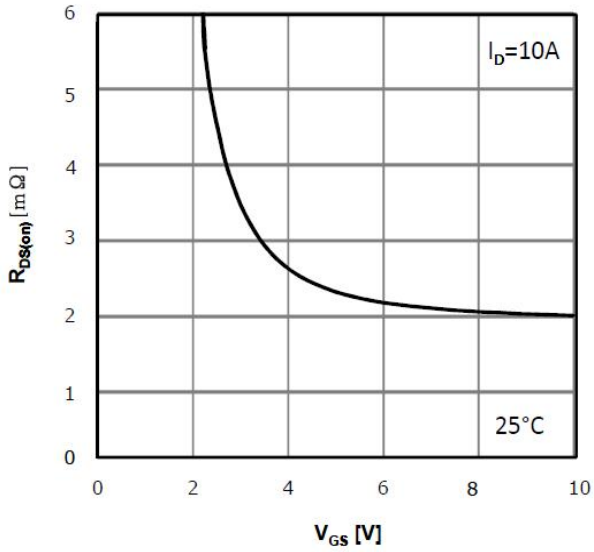
RDS(on) -- ID



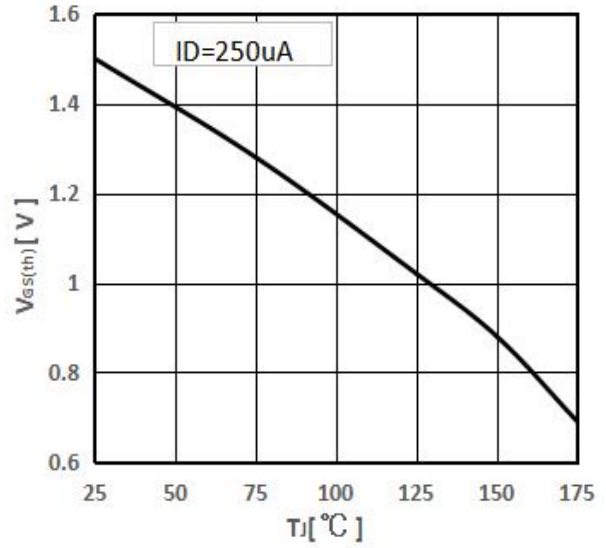
IS -- VSD



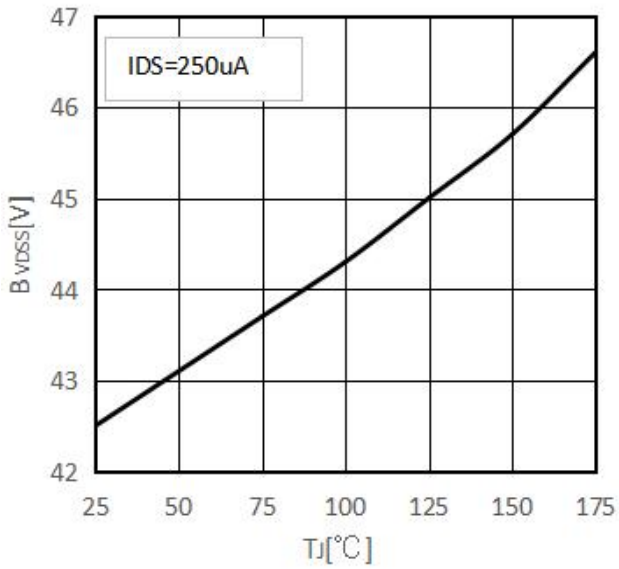
RDS(on) -- VGS



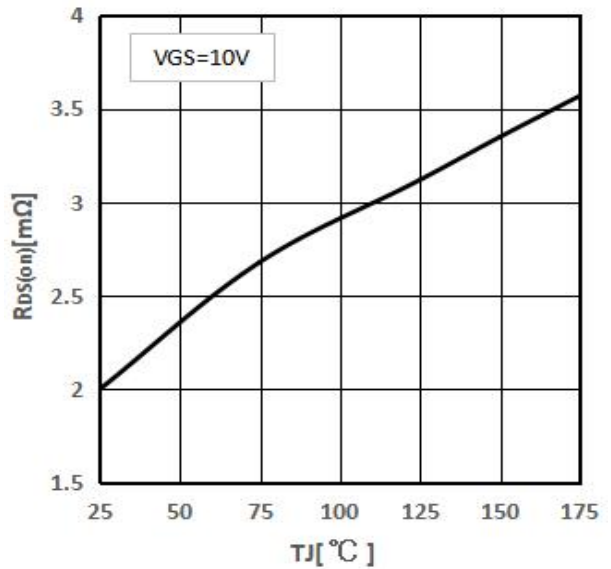
Threshold Voltage



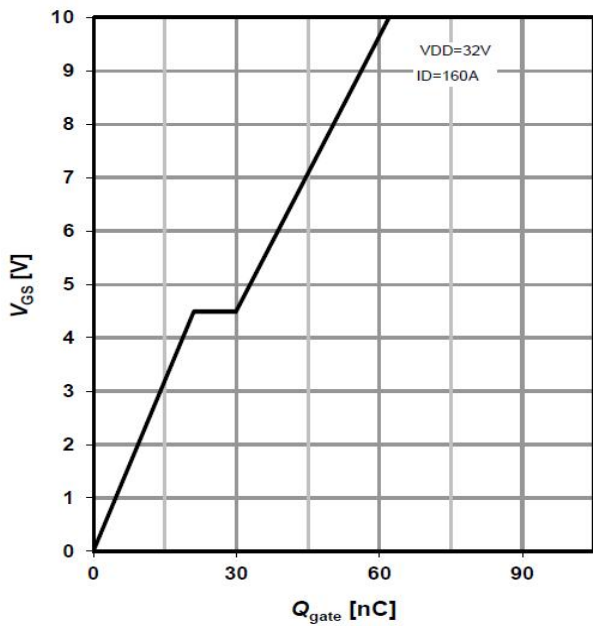
Drain-source breakdown voltage



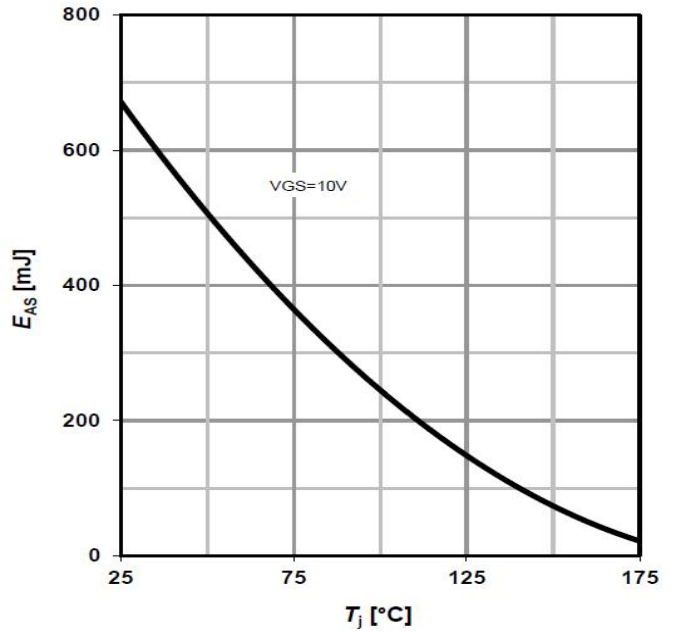
RDS (on) -- Tj



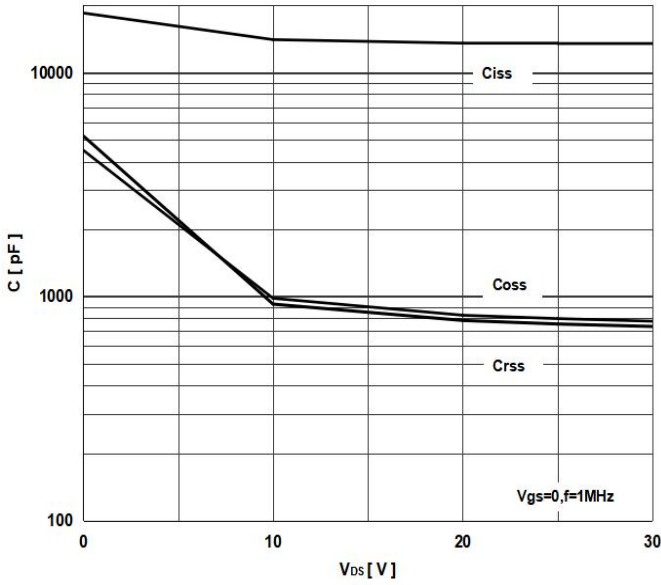
Typ.gate charge



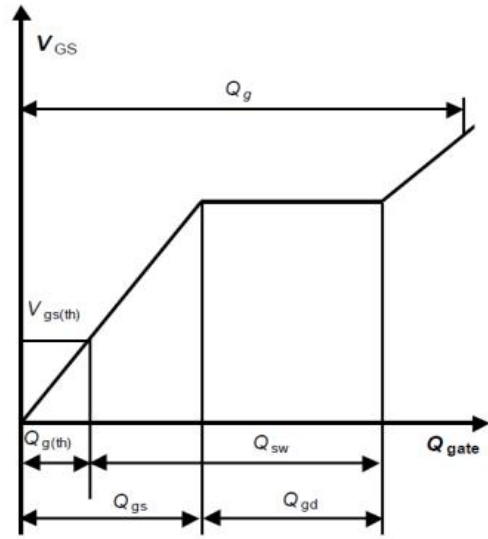
Avalanche energy



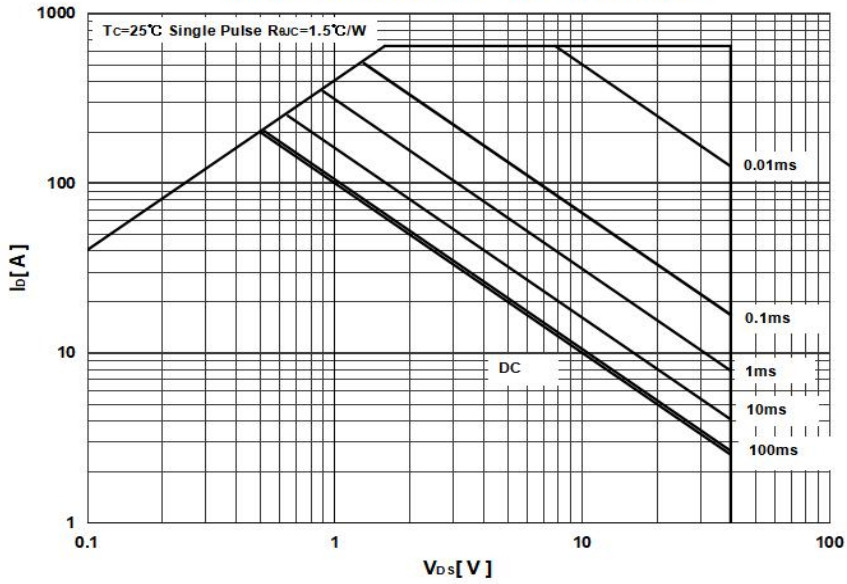
Typ. capacitance



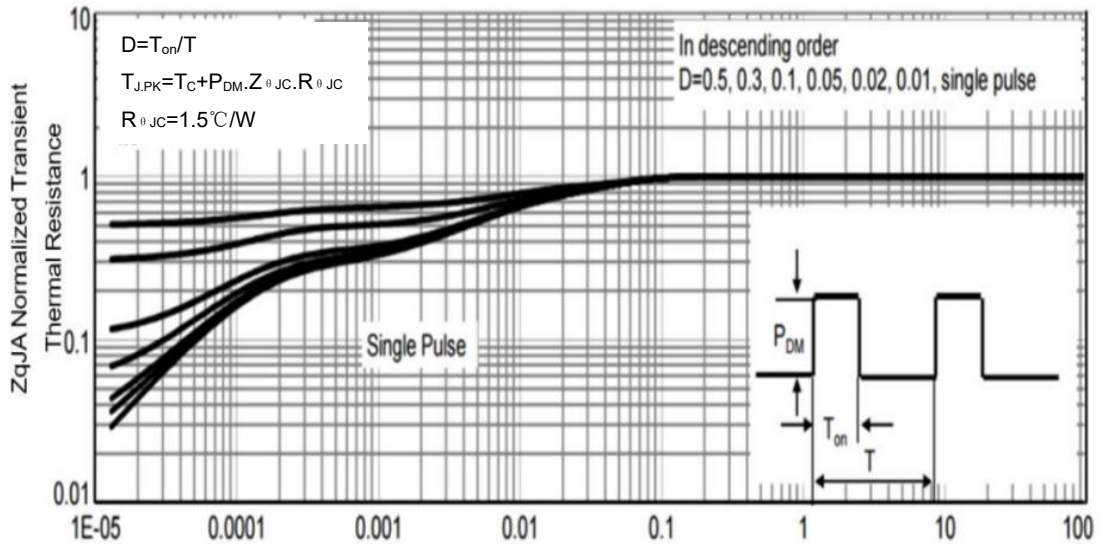
Gate charge waveforms



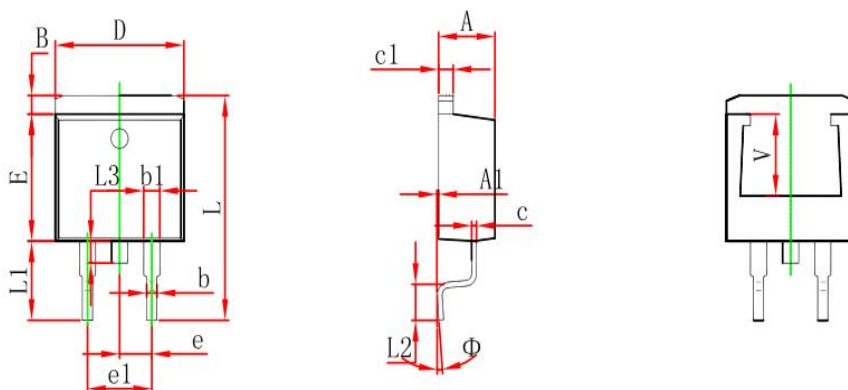
Maximum Forward Biased Safe Operating Area



Normalized Thermal Transient Impedance

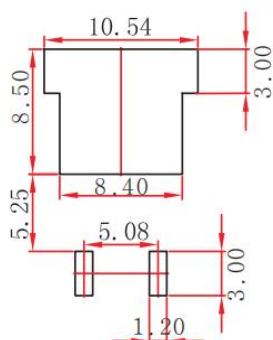


TO-263-2L Package Outline Dimensions



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	4.470	4.670	0.176	0.184
A1	0.000	0.150	0.000	0.006
B	1.120	1.420	0.044	0.056
b	0.710	0.910	0.028	0.036
b1	1.170	1.370	0.046	0.054
c	0.310	0.530	0.012	0.021
c1	1.170	1.370	0.046	0.054
D	10.010	10.310	0.394	0.406
E	8.500	8.900	0.335	0.350
e	2.540 TYP.		0.100 TYP.	
e1	4.980	5.180	0.196	0.204
L	14.940	15.500	0.588	0.610
L1	4.950	5.450	0.195	0.215
L2	2.340	2.740	0.092	0.108
L3	1.300	1.700	0.051	0.067
Φ	0°	8°	0°	8°
V	5.600 REF.		0.220 REF.	

TO-263-2L Suggested Pad Layout



Note:

1. Controlling dimension: in millimeters.
2. General tolerance: 0.5mm.
3. The pad layout is for reference purposes only.

NOTICE

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Date of change	Rev #	revise content
2022/12/20	A/0	/